

# 4 Mbit (512Kb x 8) UV EPROM and OTP EPROM

■ 5V ± 10% SUPPLY VOLTAGE in READ OPERATION

■ ACCESS TIME: 35ns

■ LOW POWER CONSUMPTION:

- Active Current 30mA at 5MHz

Standby Current 100μA

■ PROGRAMMING VOLTAGE: 12.75V ± 0.25V

■ PROGRAMMING TIME: 100µs/word

ELECTRONIC SIGNATUREManufacturer Code: 20h

- Device Code: 41h

## **DESCRIPTION**

The M27C4001 is a 4 Mbit EPROM offered in the two ranges UV (ultra violet erase) and OTP (one time programmable). It is ideally suited for microprocessor systems requiring large programs and is organised as 524,288 by 8 bits.

The FDIP32W (window ceramic frit-seal package) and LCCC32W (leadless chip carrier package) have a transparent lid which allow the user to expose the chip to ultraviolet light to erase the bit pattern. A new pattern can then be written to the device by following the programming procedure.

For applications where the content is programmed only one time and erasure is not required, the M27C4001 is offered in PDIP32, PLCC32 and TSOP32 (8 x 20 mm) packages.

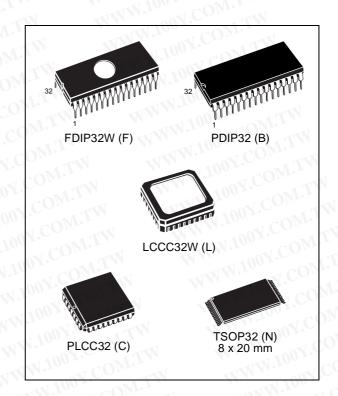
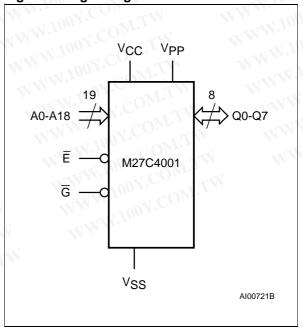


Figure 1. Logic Diagram



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Figure 2A. DIP Connections

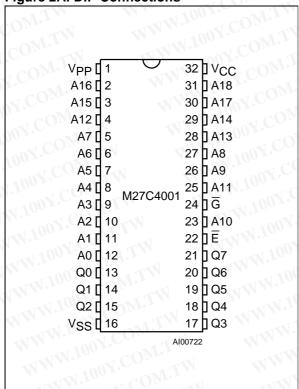


Figure 2B. LCC Connections

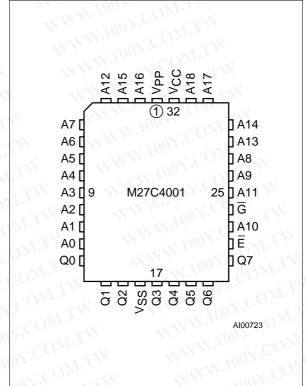
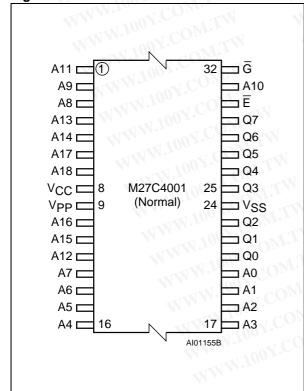


Figure 2C. TSOP Connections



**Table 1. Signal Names** 

A0-A18	Address Inputs	001.
Q0-Q7	Data Outputs	100
EW.1007.	Chip Enable	N.100
GW.1001.	Output Enable	W.10
V <sub>PP</sub>	Program Supply	NW.
/cc	Supply Voltage	WW
Vss	Ground	MW

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M27C4001

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Symbol	Parameter	Value	Unit
TA	Ambient Operating Temperature (3)	-40 to 125	°C
T <sub>BIAS</sub>	Temperature Under Bias	-50 to 125	°C
T <sub>STG</sub>	Storage Temperature	-65 to 150	°C
V <sub>IO</sub> (2)	Input or Output Voltage (except A9)	-2 to 7	V
V <sub>CC</sub>	Supply Voltage	-2 to 7	V
V <sub>A9</sub> (2)	A9 Voltage	-2 to 13.5	V
V <sub>PP</sub>	Program Supply Voltage	-2 to 14	V

Note: 1. Except for the rating "Operating Temperature Range", stresses above those listed in the Table "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the Operating sections of this specification is not implied. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability. Refer also to the STMicroelectronics SURE Program and other relevant qual-

2. Minimum DC voltage on Input or Output is -0.5V with possible undershoot to -2.0V for a period less than 20ns. Maximum DC voltage on Output is VCC +0.5V with possible overshoot to VCC +2V for a period less than 20ns.

Table 3. Operating Modes (1)

Mode	I.T. E	G 100	A9	V <sub>pp</sub>	Q7 - Q0
Read	VIL	VIL	X	V <sub>CC</sub> or V <sub>SS</sub>	Data Out
Output Disable	VIL	VIH	X	V <sub>CC</sub> or V <sub>SS</sub>	Hi-Z
Program	V <sub>IL</sub> Pulse	V <sub>IH</sub>	X	V <sub>PP</sub>	Data In
Verify	VIH	V <sub>IL</sub>	100, X	V <sub>PP</sub>	Data Out
Program Inhibit	VIH	V <sub>IH</sub>	1100 X	V <sub>PP</sub>	Hi-Z
Standby	VIH	X	100X	V <sub>CC</sub> or V <sub>SS</sub>	Hi-Z
Electronic Signature	VIL	V <sub>IL</sub>	V <sub>ID</sub>	Vcc	Codes

### **Table 4. Electronic Signature**

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**Table 5. AC Measurement Conditions** 

OW.TW W. 100 1.	High Speed	Standard
Input Rise and Fall Times	≤ 10ns	≤ 20ns
Input Pulse Voltages	0 to 3V	0.4 to 2.4V
Input and Output Timing Ref. Voltages	1.5V	0.8 and 2V

Figure 3. AC Testing Input Output Waveform

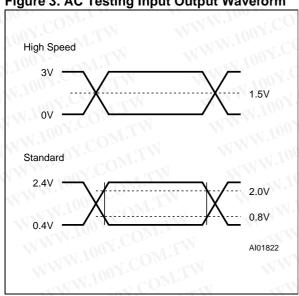


Figure 4. AC Testing Load Circuit

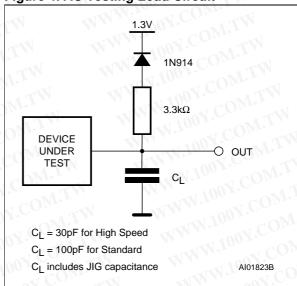


Table 6. Capacitance (1)  $(T_A = 25 \, ^{\circ}\text{C}, f = 1 \, \text{MHz})$ 

Symbol	Parameter	Test Condition	Min	Max	Unit
C <sub>IN</sub>	Input Capacitance	V <sub>IN</sub> = 0V	TOW.TW	6	pF
C <sub>OUT</sub>	Output Capacitance	V <sub>OUT</sub> = 0V	COM.TY	12	pF

Note: 1. Sampled only, not 100% tested.

#### **DEVICE OPERATION**

The operating modes of the M27C4001 are listed in the Operating Modes table. A single power supply is required in the read mode. All inputs are TTL levels except for VPP and 12V on A9 for Electronic Signature.

#### **Read Mode**

The M27C4001 has two control functions, both of which must be logically active in order to obtain data at the outputs. Chip Enable  $(\overline{E})$  is the power control and should be used for device selection. Output Enable  $(\overline{G})$  is the output control and should be used to gate data to the output pins, independent of device selection. Assuming that the ad-WWW.100Y.COM.TW

dresses are stable, the address access time  $(t_{AVQV})$  is equal to the delay from  $\overline{E}$  to output (t<sub>ELQV</sub>). Data is available at the output after a delay of  $t_{GLOV}$  from the falling edge of  $\overline{G}$ , assuming that E has been low and the addresses have been stable for at least tAVQV-tGLQV.

#### Standby Mode

The M27C4001 has a standby mode which reduces the supply current from 30mA to 100µA. The M27C4001 is placed in the standby mode by applying a CMOS high signal to the E input. When in the standby mode, the outputs are in a high impedance state, independent of the  $\overline{G}$  input.

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# Table 7. Read Mode DC Characteristics (1)

 $(T_A = 0 \text{ to } 70 \text{ °C or } -40 \text{ to } 85 \text{ °C}; V_{CC} = 5V \pm 5\% \text{ or } 5V \pm 10\%; V_{PP} = V_{CC})$ 

Symbol	Parameter	Test Condition	Min	Max	Unit
Olli	Input Leakage Current	$0V \le V_{IN} \le V_{CC}$	100 Y.CO	±10	μΑ
ILO	Output Leakage Current	$0V \le V_{OUT} \le V_{CC}$	· CON	±10	μΑ
Icc	Supply Current	$\overline{E} = V_{IL}, \overline{G} = V_{IL},$ $I_{OUT} = 0mA, f = 5MHz$	N.100X.CO	30	mA
I <sub>CC1</sub>	Supply Current (Standby) TTL	$\overline{E} = V_{IH}$	101.1001.	OMIT	mA
I <sub>CC2</sub>	Supply Current (Standby) CMOS	$\overline{E} > V_{CC} - 0.2V$	W 1007.	100	μΑ
I <sub>PP</sub>	Program Current	$V_{PP} = V_{CC}$	100Y	10	μΑ
VIL	Input Low Voltage	OY.CO.MITW	-0.3	0.8	V
V <sub>IH</sub> <sup>(2)</sup>	Input High Voltage	ON.CONTY	2	V <sub>CC</sub> + 1	V
V <sub>OL</sub>	Output Low Voltage	I <sub>OL</sub> = 2.1mA	WWW	0.4	V
W.100	Output High Voltage TTL	$I_{OH} = -400 \mu A$	2.4	ON.CO	V
Voh	Output High Voltage CMOS	I <sub>OH</sub> = -100μA	V <sub>CC</sub> - 0.7V	. OUT.CC	V

Note: 1. V<sub>CC</sub> must be applied simultaneously with or before V<sub>PP</sub> and removed simultaneously or after V<sub>PP</sub>.

2. Maximum DC voltage on Output is  $V_{CC}$  +0.5V.

# Table 8A. Read Mode AC Characteristics (1)

 $(T_A = 0 \text{ to } 70 \text{ °C or } -40 \text{ to } 85 \text{ °C}; V_{CC} = 5V \pm 5\% \text{ or } 5V \pm 10\%; V_{PP} = V_{CC})$ 

	N.=	Y.CO. TW	WW 100	Y.CO		M270	C4001			
Symbol	Alt	Parameter	Test Condition	-35	<sup>(3)</sup>	<b>V</b> -45	5 <sup>(3)</sup>	-55	(3)	Unit
	MN.7	ON.COM.	MMM.To	Min	Max	Min	Max	Min	Max	OY.C
t <sub>AVQV</sub>	t <sub>ACC</sub>	Address Valid to Output Valid	$\overline{E} = V_{IL}, \overline{G} = V_{IL}$	1001	35	WT.1	45	WV	55	ns
t <sub>ELQV</sub>	t <sub>CE</sub>	Chip Enable Low to Output Valid	$\overline{G} = V_{IL}$	1.700	35	MT	45	N	55	ns
t <sub>GLQV</sub>	toE	Output Enable Low to Output Valid	$\overline{E} = V_{IL}$	W.10	20	DM	25		30	ns
t <sub>EHQZ</sub> (2)	t <sub>DF</sub>	Chip Enable High to Output Hi-Z	$\overline{G} = V_{IL}$	0	30	0	30	0	30	ns
t <sub>GHQZ</sub> (2)	t <sub>DF</sub>	Output Enable High to Output Hi-Z	E = V <sub>IL</sub>	0	30	1.00	30	0	30	ns
t <sub>AXQX</sub>	toH	Address Transition to Output Transition	$\overline{E} = V_{IL}, \overline{G} = V_{IL}$	0	W.10	0	OM.	0	4	ns

3. Speed obtained with High Speed AC measurement conditions.

### **Two Line Output Control**

Because EPROMs are usually used in larger memory arrays, this product features a 2 line control function which accommodates the use of multiple memory connection. The two line control function allows:

- a. the lowest possible memory power dissipation,
- b. complete assurance that output bus contention will not occur.

For the most efficient use of these two control lines, E should be decoded and used as the primary device selecting function, while G should be made a common connection to all devices in the array and connected to the READ line from the system control bus. This ensures that all deselected memory devices are in their low power standby mode and that the output pins are only active when data is required from a particular memory device.

Table 8B. Read Mode AC Characteristics (1)

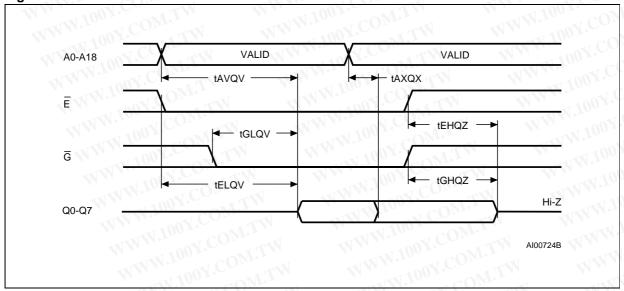
 $(T_A = 0 \text{ to } 70 \text{ °C or } -40 \text{ to } 85 \text{ °C}; V_{CC} = 5V \pm 5\% \text{ or } 5V \pm 10\%; V_{PP} = V_{CC})$ 

		MMM	WILL	W		M270	24001			
Symbol	Alt	Parameter	Test Condition	157	70	-80	/-90	-10/-1	2/-15	Unit
		WWW.100Y	CONT.	Min≤	Max	Min	Max	Min	Max	
t <sub>AVQV</sub>	tACC	Address Valid to Output Valid	$\overline{E} = V_{IL}, \overline{G} = V_{IL}$		70	W.10	80	OM.	100	ns
t <sub>ELQV</sub>	t <sub>CE</sub>	Chip Enable Low to Output Valid	$\overline{G} = V_{IL}$		70	NW.	80	$co_{M}$	100	ns
tGLQV	toE	Output Enable Low to Output Valid	$\overline{E} = V_{IL}$	N	35	WW	40	*1 CO	50	ns
t <sub>EHQZ</sub> (2)	t <sub>DF</sub>	Chip Enable High to Output Hi-Z	$\overline{G} = V_{IL}$	0	30	0	30	o.C	30	ns
t <sub>GHQZ</sub> (2)	t <sub>DF</sub>	Output Enable High to Output Hi-Z	E = V <sub>IL</sub>	0	30	0	30	0	30	ns
t <sub>AXQX</sub>	toH	Address Transition to Output Transition	$\overline{E} = V_{IL}, \overline{G} = V_{IL}$	0	N	0	WW	0	I.CO	ns

Note: 1. V<sub>CC</sub> must be applied simultaneously with or before V<sub>PP</sub> and removed simultaneously or after V<sub>PP</sub>.

2. Sampled only, not 100% tested.

Figure 5. Read Mode AC Waveforms



#### **System Considerations**

The power switching characteristics of Advanced CMOS EPROMs require careful decoupling of the devices. The supply current,  $I_{CC}$ , has three segments that are of interest to the system designer: the standby current level, the active current level, and transient current peaks that are produced by the falling and rising edges of  $\overline{E}$ . The magnitude of the transient current peaks is dependent on the capacitive and inductive loading of the device at the output. The associated transient voltage peaks can be suppressed by complying with the two line

output control and by properly selected decoupling capacitors. It is recommended that a  $0.1\mu F$  ceramic capacitor be used on every device between  $V_{CC}$  and  $V_{SS}$ . This should be a high frequency capacitor of low inherent inductance and should be placed as close to the device as possible. In addition, a  $4.7\mu F$  bulk electrolytic capacitor should be used between  $V_{CC}$  and  $V_{SS}$  for every eight devices. The bulk capacitor should be located near the power supply connection point. The purpose of the bulk capacitor is to overcome the voltage drop caused by the inductive effects of PCB traces.

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Table 9. Programming Mode DC Characteristics (1)

 $(T_A = 25 \text{ °C}; V_{CC} = 6.25 \text{V} \pm 0.25 \text{V}; V_{PP} = 12.75 \text{V} \pm 0.25 \text{V})$ 

Symbol	Parameter	Test Condition	Min	Max	Unit
Oil	Input Leakage Current	$0 \le V_{IN} \le V_{CC}$	1100Y.C	±10	μΑ
Clcc	Supply Current	WIN WIN	100Y.	50	mA
Ірр	Program Current	$\overline{E} = V_{IL}$	1005	50	mA
VIL	Input Low Voltage	ACOMIN M.	-0.3	0.8	V
VIH	Input High Voltage	M.COM W	2	V <sub>CC</sub> + 0.5	TWV
V <sub>OL</sub>	Output Low Voltage	I <sub>OL</sub> = 2.1mA	NWW	0.4	TV
V <sub>OH</sub>	Output High Voltage TTL	Ι <sub>ΟΗ</sub> = -400μΑ	2.4	100 A CO.	V
V <sub>ID</sub>	A9 Voltage	CON CTW	11.5	12.5	V

# Table 10. Programming Mode AC Characteristics (1)

Symbol	Alt	Parameter	Test Condition	Min	Max	Unit
tAVEL	t <sub>AS</sub>	Address Valid to Chip Enable Low	V.COM.	2	W.To.	μs
t <sub>QVEL</sub>	t <sub>DS</sub>	Input Valid to Chip Enable Low	ON COM.	2	MM.To	μs
tvphel	tvps	V <sub>PP</sub> High to Chip Enable Low	ON COM.	2	IMM To	μs
t <sub>VCHEL</sub>	t <sub>VCS</sub>	V <sub>CC</sub> High to Chip Enable Low	Ing COM.	2	WWW.	μs
teleh	t <sub>PW</sub>	Chip Enable Program Pulse Width	Troo COM.	95	105	μs
t <sub>EHQX</sub>	t <sub>DH</sub>	Chip Enable High to Input Transition	M.100X.COM.	2	WWW	μs
t <sub>QXGL</sub>	toes	Input Transition to Output Enable Low	M.M.100X.COM	2	W	μs
t <sub>GLQV</sub>	toE	Output Enable Low to Output Valid	MM. Too CO	T. I	100	ns
t <sub>GHQZ</sub>	t <sub>DFP</sub>	Output Enable High to Output Hi-Z	M.M. Tan C.C.C	0	130	ns
t <sub>GHAX</sub>	t <sub>AH</sub>	Output Enable High to Address Transition	WWW.100Y.C	0		ns

Note: 1. V<sub>CC</sub> must be applied simultaneously with or before V<sub>PP</sub> and removed simultaneously or after V<sub>PP</sub>.

2. Sampled only, not 100% tested.

# **Programming**

When delivered (and after each erasure for UV EPROM), all bits of the M27C4001 are in the '1' state. Data is introduced by selectively programming '0's into the desired bit locations. Although only '0's will be programmed, both '1's and '0's can be present in the data word. The only way to change a '0' to a '1' is by die exposure to ultraviolet light (UV EPROM). The M27C4001 is in the programming mode when Version it is at 40 Text. gramming mode when V<sub>PP</sub> input is at 12.75V, G is at  $V_{IH}$  and  $\overline{E}$  is pulsed to  $V_{IL}$ . The data to be programmed is applied to 8 bits in parallel to the data output pins. The levels required for the address and data inputs are TTL. V<sub>CC</sub> is specified to be  $6.25V \pm 0.25V$ .

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Figure 6. Programming and Verify Modes AC Waveforms

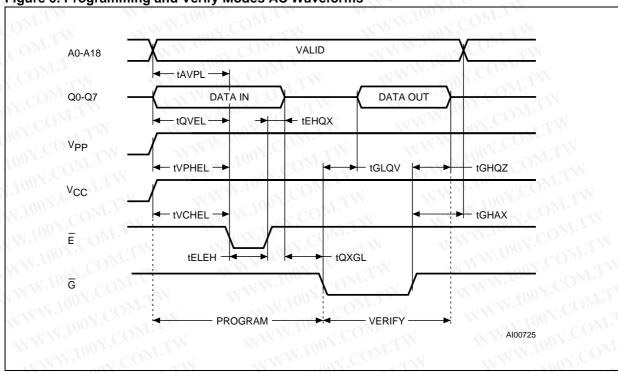
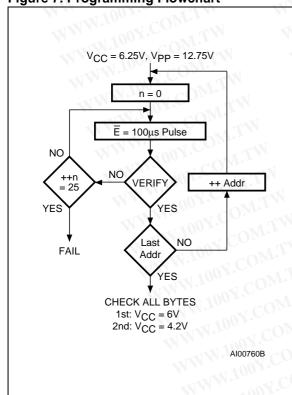


Figure 7. Programming Flowchart



#### **PRESTO II Programming Algorithm**

PRESTO II Programming Algorithm allows the whole array to be programmed with a guaranteed margin, in a typical time of 52.5 seconds. Programming with PRESTO II consists of applying a sequence of 100µs program pulses to each byte until a correct verify occurs (see Figure 7). During programming and verify operation, a MARGIN MODE circuit is automatically activated in order to guarantee that each cell is programmed with enough margin. No overprogram pulse is applied since the verify in MARGIN MODE provides the necessary margin to each programmed cell.

#### **Program Inhibit**

Programming of multiple M27C4001s in parallel with different data is also easily accomplished. Except for  $\overline{E}$ , all like inputs including  $\overline{G}$  of the parallel M27C4001 may be common. A TTL low level pulse applied to a M27C4001's  $\overline{E}$  input, with V<sub>PP</sub> at 12.75V, will program that M27C4001. A high level  $\overline{E}$  input inhibits the other M27C4001s from being programmed.

#### **Program Verify**

A verify (read) should be performed on the programmed bits to determine that they were correctly programmed. The verify is accomplished with  $\overline{G}$  at  $V_{IL}$ ,  $\overline{E}$  at  $V_{IH}$ ,  $V_{PP}$  at 12.75V and  $V_{CC}$  at 6.25V.

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M27C4001

# W.100Y.COM.TW **Electronic Signature**

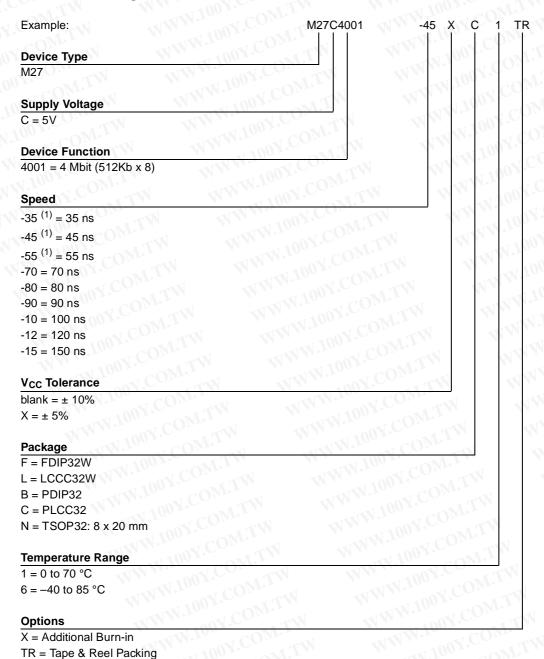
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The Electronic Signature (ES) mode allows the reading out of a binary code from an EPROM that will identify its manufacturer and type. This mode is intended for use by programming equipment to automatically match the device to be programmed with its corresponding programming algorithm. The ES mode is functional in the 25°C  $\pm$  5°C ambient temperature range that is required when programming the M27C4001. To activate the ES mode, the programming equipment must force 11.5V to 12.5V on address line A9 of the M27C4001 with  $V_{PP} = V_{CC} = 5V$ . Two identifier bytes may then be sequenced from the device outputs by toggling address line A0 from V<sub>IL</sub> to V<sub>IH</sub>. All other address lines must be held at VIL during Electronic Signature mode. Byte 0 (A0 = V<sub>IL</sub>) represents the manufacturer code and byte 1  $(A0 = V_{IH})$  the device identifier code. For the STMicroelectronics M27C4001, these two identifier bytes are given in Table 4 and can be read-out on outputs Q7 to Q0. WWW.100Y.COM.TW

## **ERASURE OPERATION (applies to UV EPROM)**

The erasure characteristics of the M27C4001 are such that erasure begins when the cells are exposed to light with wavelengths shorter than approximately 4000 Å. It should be noted that sunlight and some type of fluorescent lamps have wavelengths in the 3000-4000 Å range. Data shows that constant exposure to room level fluorescent lighting could erase a typical M27C4001 in about 3 years, while it would take approximately 1 week to cause erasure when exposed to direct sunlight. If the M27C4001 is to be exposed to these types of lighting conditions for extended periods of time, it is suggested that opaque labels be put over the M27C4001 window to prevent unintentional erasure. The recommended erasure procedure for the M27C4001 is exposure to short wave ultraviolet light which has wavelength of 2537 Å. The integrated dose (i.e. UV intensity x exposure time) for erasure should be a minimum of 15 W-sec/cm<sup>2</sup>. The erasure time with this dosage is approximately 15 to 20 minutes using an ultraviolet lamp with 12000 µW/cm<sup>2</sup> power rating. The M27C4001 should be placed within 2.5 cm (1 inch) of the lamp tubes during the erasure. Some lamps have a filter on their tubes which should be removed before erasure.

## **Table 11. Ordering Information Scheme**



Note: 1. High Speed, see AC Characteristics section for further information.

For a list of available options (Speed, Package, etc...) or for further information on any aspect of this device, please contact the STMicroelectronics Sales Office nearest to you.

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# W.100Y.COM.TW Table 12. Revision History

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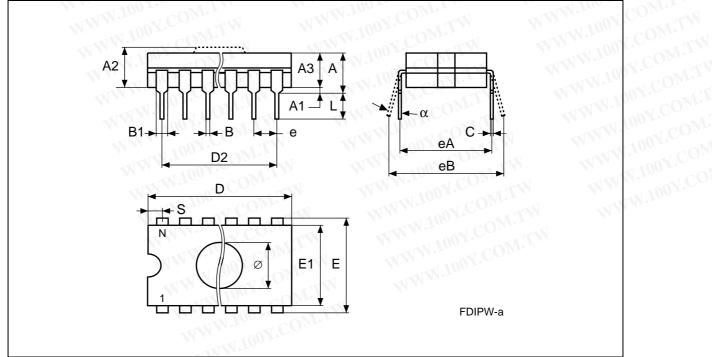
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Date July 1998	Revision Details First Issue
09/25/00	AN620 Reference removed
11/29/00	PLCC codification changed (Table 11)

Table 13. FDIP32W - 32 pin Ceramic Frit-seal DIP with window, Package Mechanical Data

	Cymphal	millimeters			inches		
	Symbol	Тур	Min	Max	Тур	Min	Max
	COA	MM	1007.Co	5.72	11/1/	T.M.T	0.225
	COA1	WW	0.51	1.40	MM	0.020	0.055
	A2	U all	3.91	4.57	MMM.	0.154	0.180
	A3	×1	3.89	4.50	WWW	0.153	0.177
	В	A)	0.41	0.56		0.016	0.022
	B1	1.45	100X	CONT.TW	0.057	N.1003.	W.T.
	C	WI	0.23	0.30		0.009	0.012
	D'COL	TW	41.73	42.04	N W	1.643	1.655
	D2 CO	38.10	W. W. IV	OA.COM	1.500	MAN OUX.	Om -TI
	W.IE	15.24	T.WW.	COM	0.600	MM-In	COME.
	E1	OWITH	13.06	13.36	, I '	0.514	0.526
	е	2.54	The state of the s	1.100 = 001	0.100	W.100	COM
	eA	14.99	-41	x 1002.	0.590	W - 10	0.4
	eB	I.COM	16.18	18.03	WILL	0.637	0.710
	WWEN.	A.COM.	3.18	M. C.	Dr. TW	0.125	ON CO
	S	COM	1.52	2.49	OM. TAN	0.060	0.098
	Ø	7.11	_	700 ×	0.280	- WW	1.100
	α	TOOX.	4°	11°	COMIT	4°	11°
	N	1007.C	32	WW 100	I. OM.TW	32	100 x

Figure 8. FDIP32W - 32 pin Ceramic Frit-seal DIP with window, Package Outline



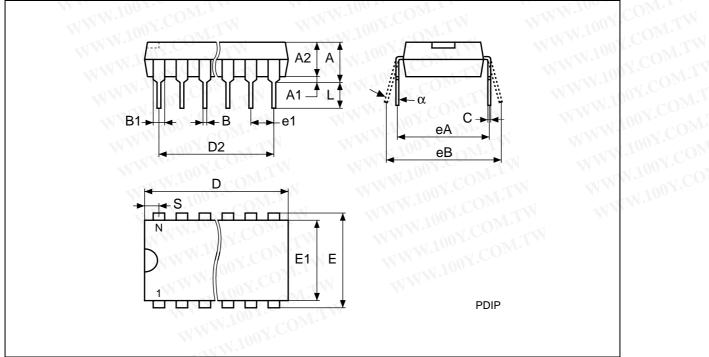
Drawing is not to scale.

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Table 14. PDIP32 - 32 lead Plastic DIP, 600 mils width, Package Mechanical Data

OM TW	NY TENNA	millimeters inches					
Symbol	Тур	Min	Max	Тур	Min	Max	
A	MM	N 1007.	5.08	10	T.MODIT	0.200	
A1	WW	0.38	M.T.W	1	0.015	_	
A2	N N	3.56	4.06	MM	0.140	0.160	
CB)	W W	0.38	0.51	MM	0.015	0.020	
B10	1.52	MANN-	COM-TAN	0.060	1100±1.CO	MITW.	
COM	TV	0.20	0.30	WW	0.008	0.012	
Joo D COJ	1.1	41.78	42.04	VVV	1.645	1.655	
1.10 D2	38.10	M.In	COM.	1.500	M.M. Jan	OM.	
W.10E	15.24	TWW.10	OM.	0.600	WILLIAM	COM	
E1	OWITH	13.59	13.84	7.4	0.535	0.545	
e1	2.54	A	700 = COJ	0.100	W.100	COM.	
eA	15.24	_0	N 7007	0.600	W W . 10	D. COM	
eB	CONTA	15.24	17.78	W.TW	0.600	0.700	
MAL	OY.CO.	3.18	3.43	W.TW	0.125	0.135	
S	ON.CON	1.78	2.03	WIN	0.070	0.080	
α	ON COM.	0°	10°	CORTAN	0°	10°	
N	Tan COM	32	NWW.	32 VIV			

Figure 9. PDIP32 - 32 lead Plastic DIP, 600 mils width, Package Outline



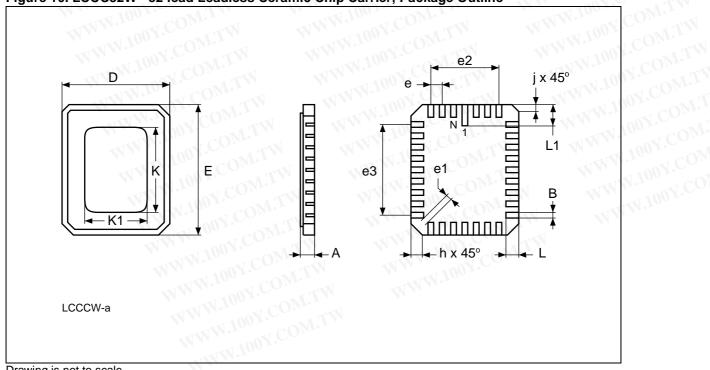
Drawing is not to scale.

V.100Y.COM.TW

Table 15. LCCC32W - 32 lead Leadless Ceramic Chip Carrier, Package Mechanical Data

Symbol	W	millimeters			inches		
	Тур	100Min	Max	Тур	Min	Max	
A	W	W.1007.	2.80	W.10	ON.	0.110	
В	WW	0.51	0.71	WW.	0.020	0.028	
DAT	W.	11.53	11.63	N V	0.442	0.458	
Y.CE	M M	13.72	14.22	MA	0.540	0.560	
o Y.e	1.27	100X	T.TW	0.050	N.1007.	M.TW	
e1	WT	0.39	I.CO.		0.015	$M.\overline{I_{\overline{M}}}$	
e2 C	7.62	MATA	N.CO.	0.300	100 Y.C	W <del>I</del> .Mo.	
e3	10.16	MAM.	OA'COB	0.400	M. 1001.	ON-TY	
h C	1.02	M-MM.	OON.COM	0.040	100X	.Co.	
W. T.	0.51	MMM.	TOON-COM	0.020	MM 7. 100	V.CO	
MAITE	COM	1.14	1.40	WT	0.045	0.055	
L1	COM	1.96	2.36	TW	0.077	0.093	
K	COM.	10.50	10.80	OM	0.413	0.425	
K1	COMI	8.03	8.23	$CO_{M^{-1}}$	0.316	0.324	
N.	On COM.	32	77W.100	COM	32	Trans C	

Figure 10. LCCC32W - 32 lead Leadless Ceramic Chip Carrier, Package Outline

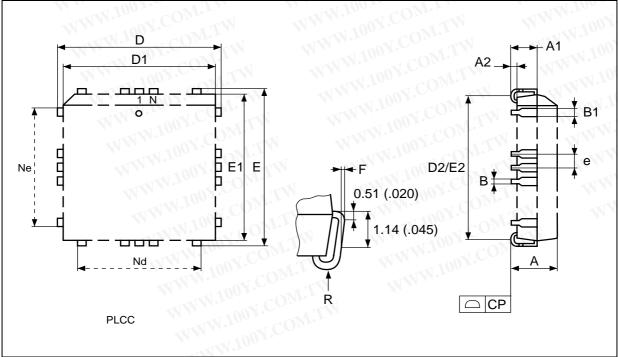


Drawing is not to scale.

Table 16. PLCC32 - 32 lead Plastic Leaded Chip Carrier, Package Mechanical Data

N 1007.	Symbol	111	millimeters			inches		
1100Y.CC	Symbol	Тур	Min	Max	Тур	Min	Max	
W. TOON.C	A	MM	2.54	3.56	WW 10	0.100	0.140	
VVI.TOOX.	COA1	WW	1.52	2.41	WW	0.060	0.095	
MM.Joo	A2	V W	0.38	ON. TW	MM	0.015	TW	
M.10	В	XV XX	0.33	0.53	WWW	0.013	0.021	
100 100	B1		0.66	0.81	WW	0.026	0.032	
10	DOW	LA	12.32	12.57		0.485	0.495	
WW 1	00 D1	1.1.11	11.35	11.56		0.447	0.455	
WW	D2	u.TN	9.91	10.92		0.390	0.430	
MM	e V.C	1.27	MM	MY.COM!	0.050	11 100x.	COMT	
WWW	E.V.C	WT	14.86	15.11	TW	0.585	0.595	
WW	W-E1(	ON	13.89	14.10	TW	0.547	0.555	
	E2	COMP	12.45	13.46	TW	0.490	0.530	
	F.100	COM	0.00	0.25	) NI.	0.000	0.010	
77	R 100	0.89	1	W.100	0.035	T.WW.	CO.	
	N N 10	T. COM.T.	32	71W.100 x	OWIT	32	100 - C	
	Nd	OV.	7	W.100Y	COMITY	7	1.100	
	Ne	100 X.Co.	9	N.M. 100	MIM	9	N.100 Y.	
	СР	ON COM	W	0.10	T.CO. TIN	MM	0.004	





Drawing is not to scale.

Http://www. 100y. com. tw

Table 17. TSOP32 - 32 lead Plastic Thin Small Outline, 8 x 20 mm, Package Mechanical Data

Symbol	millimeters			inches		
Symbol	Тур	Min	Max	Тур	Min	Max
A	MA	W.100Y.	1.20	W.10	COWI	0.047
A1		0.05	0.17	W TW.	0.002	0.006
A2		0.95	1.05	N	0.037	0.041
В		0.15	0.27	MA	0.006	0.011
00 Y.C	TW	0.10	0.21	MA	0.004	0.008
100 DCO	TW	19.80	20.20	N W	0.780	0.795
D1.CO	WT	18.30	18.50	M M	0.720	0.728
EY.CC	WT	7.90	8.10	W W	0.311	0.319
e C	0.50	W-MM.	OUN.COM	0.020	1007	CONTITY
M.F.	OM	0.50	0.70	ITW	0.020	0.028
α	COM	0°	5°	WT	0°	5°
N.100	COM	32	M. Jan. C.C.	JAZ.	32	WA'COM
СР	*1 COM.	oli -xIV	0.10	OM.	WWW.	0.004

Figure 12. TSOP32 - 32 lead Plastic Thin Small Outline, 8 x 20 mm, Package Outline

A2

D1

D1

D1

A1

A1

A1

A1

A1

Drawing is not to scale.